

Notice of References Cited

Application/Control No.

10/542,406

Applicant(s)/Patent Under
Reexamination
VERNEAU, BERNADETTE

Examiner

QIUWEN MI

Art Unit

1655

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*	B	US-2002/0192308	12-2002	Mamana, John	424/729
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	N	GB 2367493 A	04-2002	United Kingdom	MERNAGH et al.	-----
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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